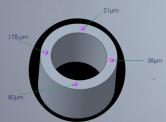


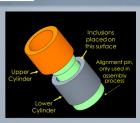
# Identification of Voids & Inclusions in Z Targets\* M. Rich<sup>1</sup>, K. Tomlinson<sup>1</sup>, R. Holf<sup>1</sup>, R. Paguio<sup>1</sup>

## **OVERVIEW**

- · Voids and inclusions in Be targets for the Z machine can cause instabilities during implosion.
- · All target bodies are scanned using CT before assembly to identify and characterize voids and inclusions.
- · Theoretically the smallest detectable defect must be covered by a 2v\*2v\*2v matrix (v=voxel size)
- Creating parts with known defect sizes/locations will allow validation of CT measurements.
- The purpose of this is to validate the detection abilities of the CT machine and current methods being used.

#### **INCLUSION TARGET**



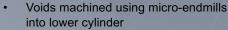


- · Stainless steel microspheres pressed in between two aluminum cylinders
- · Imitate iron inclusions found in Be targets
- · Microspheres measured using measurement microscope before assembly for comparison
- All four sizes of inclusions were able to be seen in CT scan
- · CT scan had 17.3 um voxel size
- Smallest size (21um) was not large enough to be

confidently measured

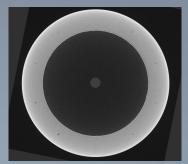


#### **VOID TARGET**



- Epoxied to upper cylinder to simulate sealed voids found inside Be targets
- Voids measured using measurement microscope for comparison.
- Smallest voids were not large enough to be measured
- All of the void sizes could be seen in CT reconstruction





### **RESULTS**

Actual Inclusion Size (µm)	CT Measured Size(µm)	% Error
21	-	-
38	46	21.1%
80	85	6.3%
178	173	2.8%

Measurements were taken using the software (NSI) of the CT machine. Measurements taken using Volume Graphics defect detection tool do not match the actual or NSI measurements.

# **NEXT STEPS**

Actual Void Diameter (µm)	CT Measured Size (µm)	% Error
51	-	-
73	90	23.3%
101	96	5.0%
138	127	8.0%
174	165	5.2%
51	-	-
71	81	14.1%
109	88	19.3%
129	125	3.1%
172	162	5.8%

- Create identical parts out of Be to more accurately assess detectability of different Z values
- Identify the proper Volume Graphics settings needed to match measurements to **NSI** measurements
- Create array of sizes to be used as Reference Quality Indicators
- Further refinement of scan parameters to minimize X-Ray artifacts